Amorphous Coatings Current Status — Future Plans

Steven Penn Hobart & William Smith Colleges

GWADW — Hawaii — May 2012

Coating Thermal Noise

 Limits the sensitivity for 2nd Generation detectors Reduced by changing (in current interferometer design) Form factor: Laguerre-Gauss beams Dissipation in the coating Redesign the coating structure: Etched Refractive layers: Jena (S. Kroker talk) Crystalline coatings: Vienna (G. Cole talk)

Reduce the loss in Amorphous Coatings



Amorphous (Metal-Oxide) Coatings

Optical Quality

- Can provide ppm level scattering and absorption
- Significant History and Industry for these coatings
- Mechanical Quality
 - Dissipation predominantly in material
 - Loss at interface still being explored

Material Structure Research: Determine loss mechanism / Redesign Coating

- Theoretical work: UFlorida & Southern U.
- Experimental work:
 - Reduced Density Function to model structure: Stanford (R. Bassiri talk)
 - Activation Energy of loss mechanisms: Glasgow (I. Martin talk)
- Optimize Coating Structure: USannio (R. DeSalvo talk)

Optimize Coating Materials: Material Selection and Processing



Optimize Amorphous Coatings: Material Properties

→ Material Properties: Ion Beam Sputtering (IBS) process alters properties

- Residual stress (compressive)
- Variable thermal annealing history (reduce stress & absorption)

Young's Modulus:

- NanoIndenter: Glasgow (M. Abernathy)
- Ultrasonic reflection: Embry-Riddle (M. Zanolin, A. Gretarsson)

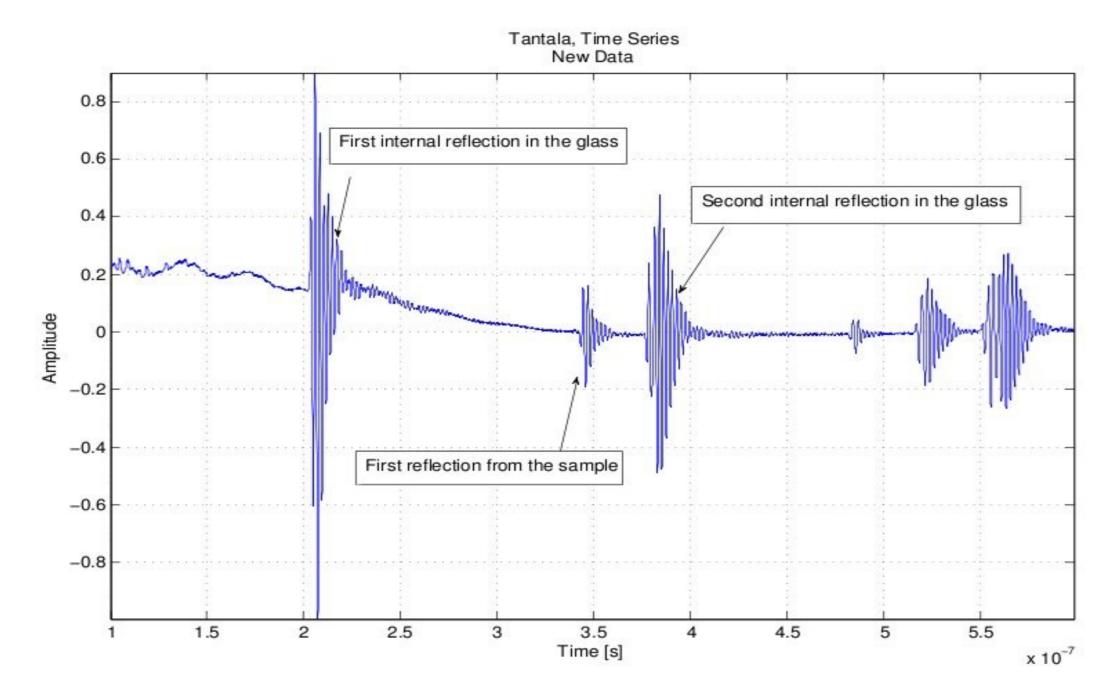
Coating Phi Components

• Torsional loss in coatings - Test ϕ_{\perp} vs ϕ_{\parallel} : American (G. Harry)

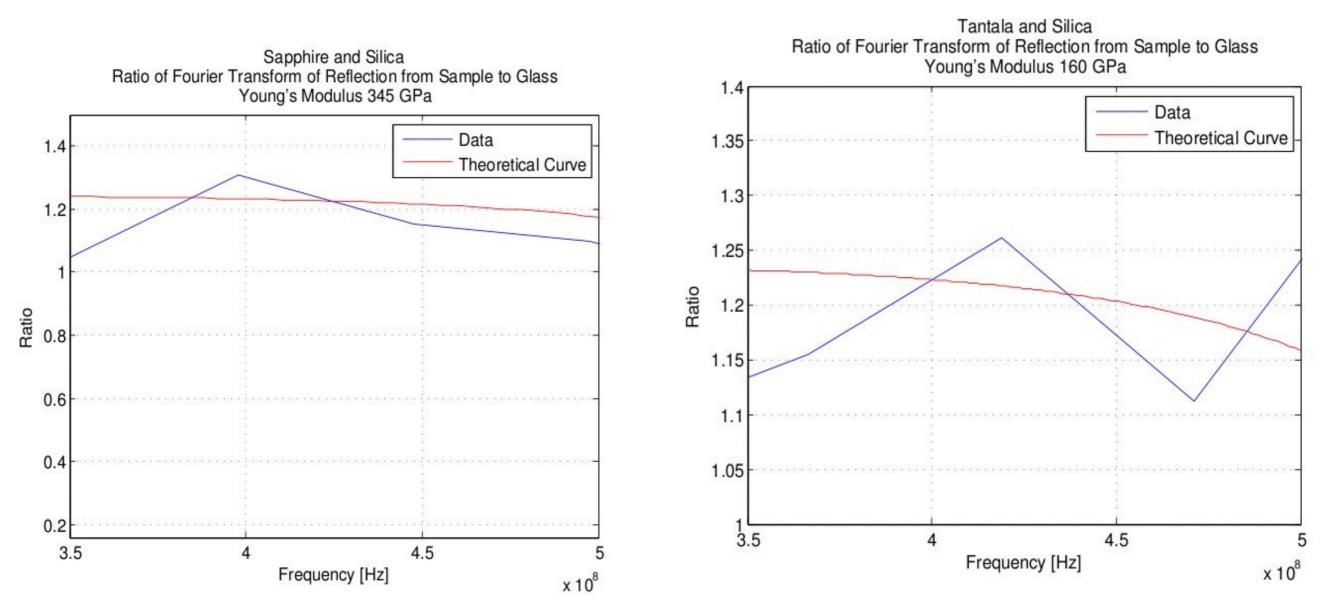
$$S_x(f)_{\text{coating}} = \frac{2k_{\rm B}T}{\pi^2 fY} \frac{d}{w_m^2} \left(\frac{Y'}{Y}\phi_{\parallel} + \frac{Y}{Y'}\phi_{\perp}\right)$$



Ultrasonic measurement of Young's modulus of LIGO coatings at ERAU A.Gretarsson,E.Gretarsson,E.Rhoades, M.Zanolin



Two examples



• The two plots show the ratio of the reflection coefficient of a sapphire substrate (left) and a 5 microns Tantala coating on a silica substrate (right) with respect to the reflection coefficient of a silica substrate. The blue curve is the average spectrum of 5 measurements and the red is a theoretical one where the free parameter is the YM of the testing sample (pure sapphire and Tantala coating). The quoted estimate above the pictures is a least square estimate.

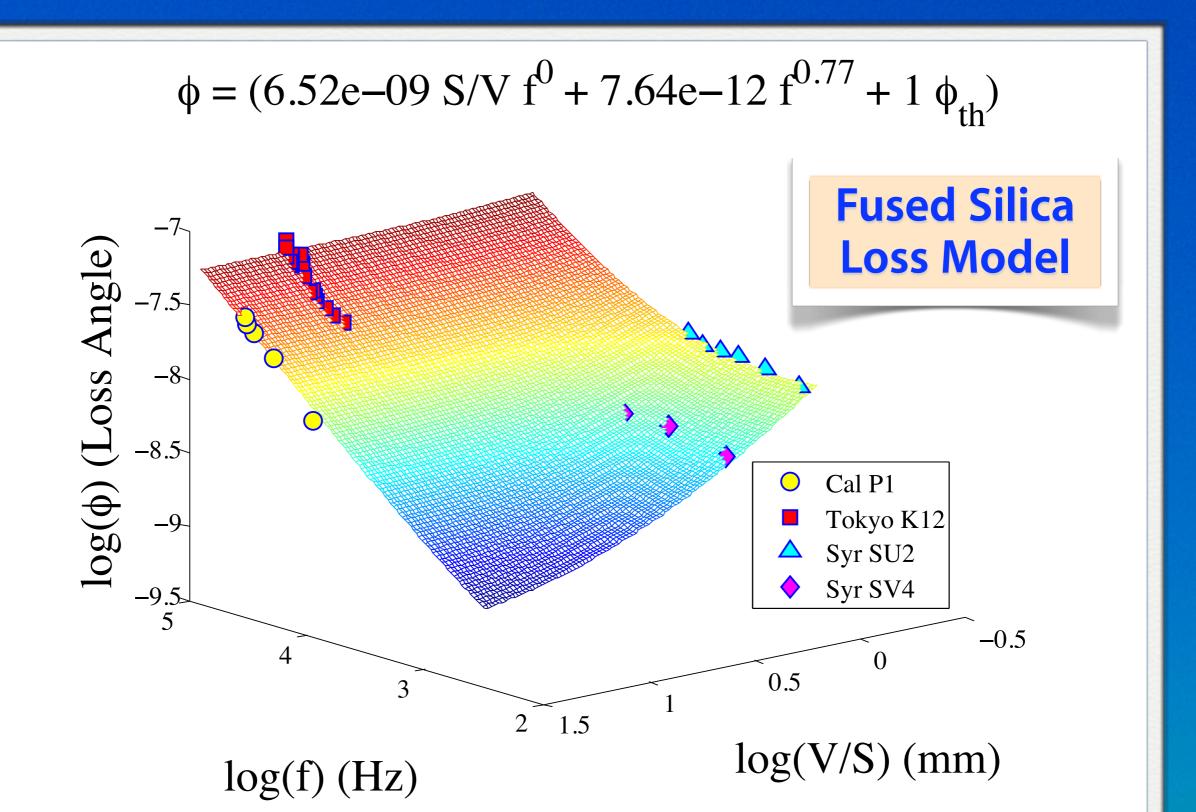
Optimize Amorphous Coatings: Material Selection

+ High Index: Tantala, Titania, ... Zirconia, Niobia, Hafnia

- Loss as coated are comparable: few x 10⁻⁴
- → Tantala: Moderately stable (300–400° C), $n \approx 2.1$
- → Titania: Less stable (200° C). $n \approx 2.5$
- Zirconia: High Absorption, 10-50 ppm
- ♦ Niobia: High loss 4.5 x 10⁻⁴
- Doped High-Index Materials:
 - Titania(20%)-Tantala:
 - ♦ Lowers loss to 2 x 10⁻⁴, Stabilizes Titania, index admixture
 - Measurements to 55%-doping under analysis. Proposed 90% run.
 - Silica-doped (Titania/Tantala/...)
 - Stabilizes high-index material
 - Lowers index mixture determines index
 - Little gain in loss



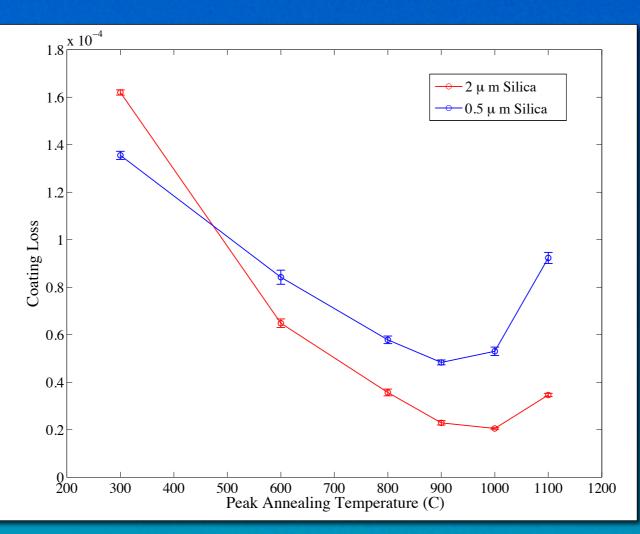
Optimize Amorphous Coatings: Silica
 ◆ Silica: Loss Model. Lowest loss φ ≈ 5 × 10⁻⁹
 ◆ Coating loss is well measured as bulk and as a coating.



Optimize Amorphous Coatings: Annealing

Annealing: Provided that the sample remain amorphous

- Reduces mechanical loss by a factor of few to several depending on the material. (8x for 2 micron silica)
- Reduces optical absorption by equally larger factor (zirconia reduced from 100 ppm to 10 ppm by 900° C)





Optimized Coatings via Annealing

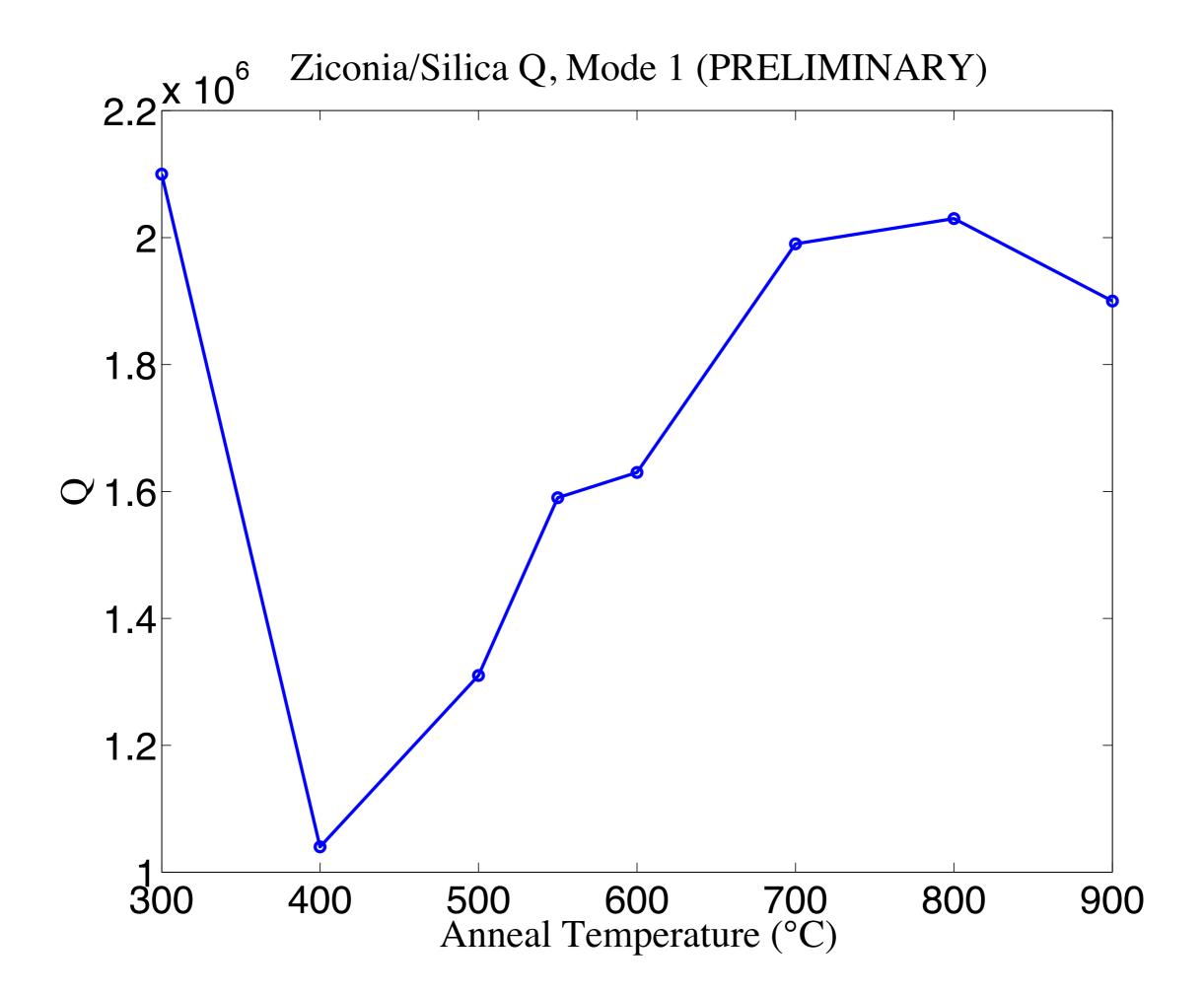
1) Select, or mix, a high-index coating material

- 1) Match the CTE to silica (or low-index material)
- 2) Dope against crystallization
- 2) Make a quarter-wavelength multilayer
- 3) Anneal to 1000° C

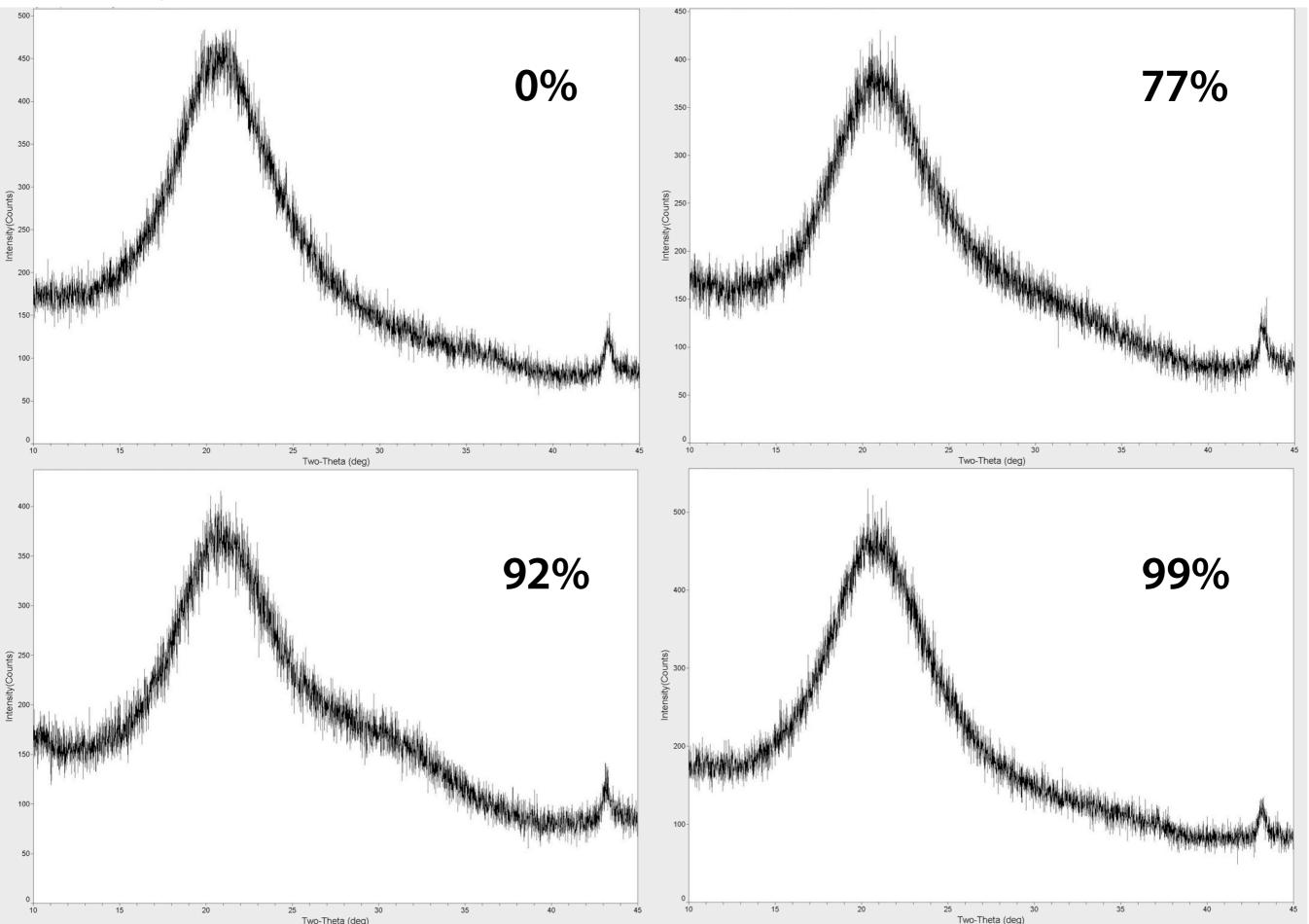


Zirconia/Silica Coating (2 λ/4 doublets)

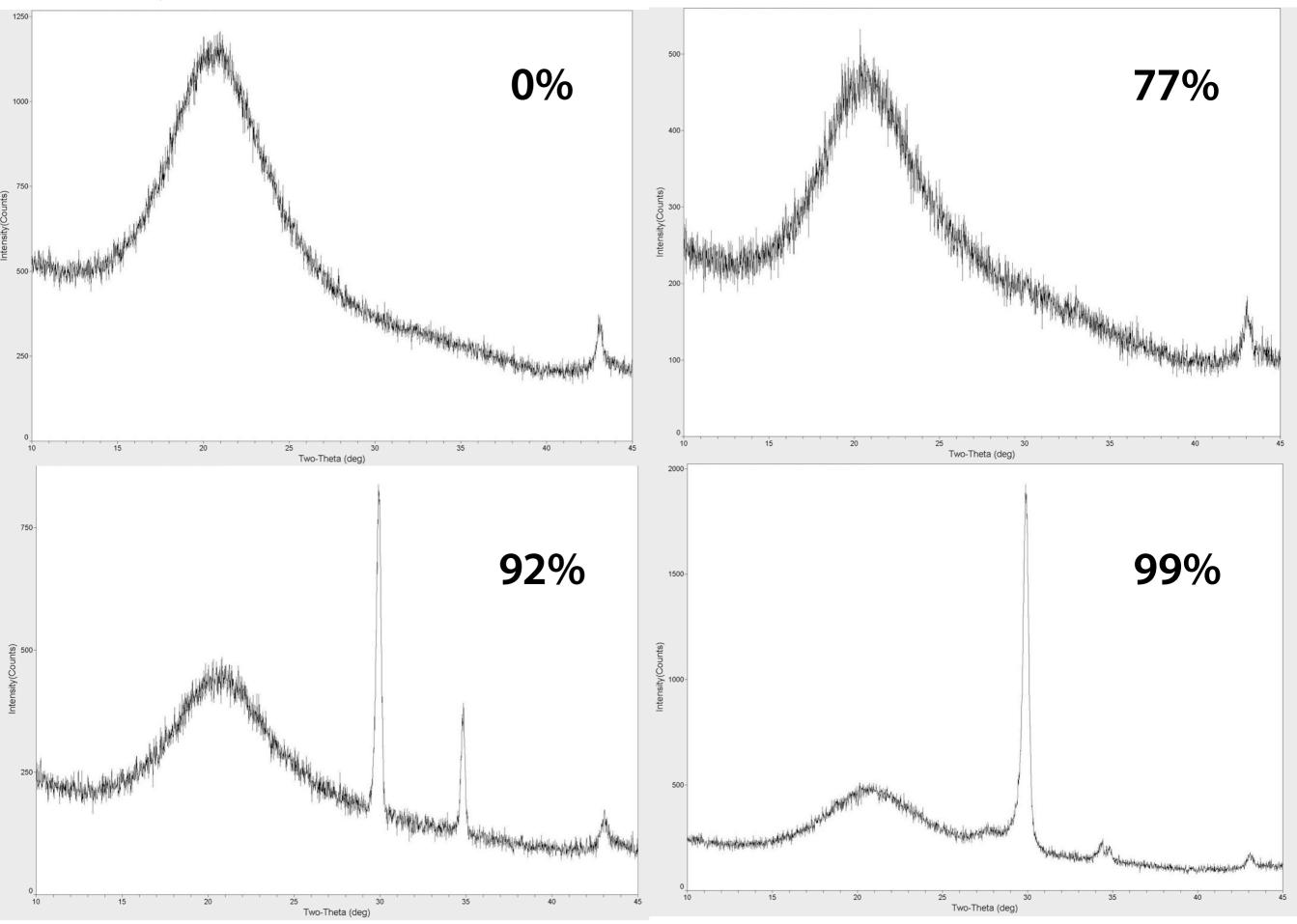
- + Annealed up to 1000°C
- + No peeling, bubbles, crazing, or loss of adhesion.
- + At 1000° C, excess scatter detectable with naked eye.
- + X-ray diffraction shows crystallization
- Scatter only 10x than superpolished sample
- + Absorption \approx < 10 ppm



X-ray Diffraction of Silica-doped Zirconia, Anneal $\approx 300^\circ$ C



X-ray Diffraction of Silica-doped Zirconia, Anneal $\approx 600^\circ$ C



Summary

- IBS produced Amorphous coatings can provide the required optical qualities for Advanced Generation of detectors.
- Current coating loss "acceptable", but should be improved
- Considerable effort being devoted to characterize and understand the physical characteristics, structure, and loss mechanisms of amorphous coatings.
- Doping has provided the most significant improvement (≈40%) in a complete multilayer coating (Ti-doped-Tantala/Silica)
- Annealing has shown improvements of few-several in the loss.
- Silica-doped Zirconia is a test of principle.

